


<b>Search Notes</b>  	<b>Application/Control No.</b>  10715597	<b>Applicant(s)/Patent Under Reexamination</b>  SHAMOON ET AL.
	<b>Examiner</b>  APRIL Y SHAN	<b>Art Unit</b>  2435

SEARCHED			
Class	Subclass	Date	Examiner
380	210, 239, 43, 232, 217, 287, 54, 231 and 201	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
704	503, 504	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
726	26, 27	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.

SEARCH NOTES		
Search Notes	Date	Examiner
Updated text search in EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
Double patenting search by searching inventor's names	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
NPL search (Google search inventor's NPL publication, Google scholar, ACM)	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
713/193 and 380/28 (Limited by text only)	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.
Consult with Primary examiner, Ponnoreay Pich (AU 2435) on allowability	12/14/2009	a.s.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See search history tagged with "Interference Search" (USPAT; US-PGPUB)	6/17/2009 and 12/14/2009 and 6/11/2010	a.s.

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